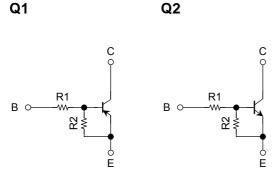
TOSHIBA Transistor Silicon PNP · NPN Epitaxial Type (PCT process) (Bias Resistor built-in Transistor)

# **RN4901FF**

Switching, Inverter Circuit, Interface Circuit and Driver Circuit Applications.

- Two devices are incorporated into an Extreme-Super-Mini (6 pin) ٠ package.
- Incorporating a bias resistor into a transistor reduces parts count. Reducing the parts count enable the manufacture of ever more compact equipment and save assembly cost.

#### **Equivalent Circuit and Bias Resistor Values**

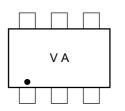


R1: 4.7 kΩ

R2: 4.7 kΩ

(Q1, Q2 common)

#### Marking



#### (E1) (E1) (B1) 0.12±0.05 2. BASE1 3. COLLECTOR2 (C2) 4. EMITTER2 (E2) 5. BASE2 (B2) 6. COLLECTOR1 (C1) ES6 JEDEC \_ JEITA \_\_\_\_ TOSHIBA \_

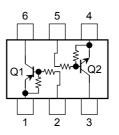
1. EMITTER1

1.0±0.05 0.5

0.5 2

Weight: g (typ.)

#### **Equivalent Circuit (top view)**



Unit: mm

 $1.6 \pm 0.05$ 1.2±0.05

6

5

0.2±0.05 I.6±0.05

05

0.55±0.

# Maximum Ratings (Ta = 25°C) (Q1)

Characteristics	Symbol	Rating	Unit
Collector-base voltage	V <sub>CBO</sub>	-50	V
Collector-emitter voltage	V <sub>CEO</sub>	-50	V
Emitter-base voltage	V <sub>EBO</sub>	-10	V
Collector current	Ι <sub>C</sub>	-100	mA

## Maximum Ratings (Ta = 25°C) (Q2)

Characteristics	Symbol	Rating	Unit
Collector-base voltage	V <sub>CBO</sub>	50	V
Collector-emitter voltage	V <sub>CEO</sub>	50	V
Emitter-base voltage	V <sub>EBO</sub>	10	V
Collector current	۱ <sub>C</sub>	100	mA

#### Maximum Ratings (Ta = 25°C) (Q1, Q2 common)

Characteristics	Symbol	Rating	Unit
Collector power dissipation	P <sub>C</sub> (Note)	100	mW
Junction temperature	Tj	150	°C
Storage temperature range	T <sub>stg</sub>	-55~150	°C

Note: Total rating

# Electrical Characteristics (Ta = 25°C) (Q1)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I <sub>CBO</sub>	$V_{CB}=-50~V,~I_{E}=0$			-100	nA
	ICEO	$V_{CE}=-50~V,~I_B=0$	_	_	-500	
Emitter cut-off current	I <sub>EBO</sub>	$V_{EB} = -10 \text{ V}, I_C = 0$	-0.82	_	-1.52	mA
DC current gain	h <sub>FE</sub>	$V_{CE} = -5 \text{ V}, \text{ I}_{C} = -10 \text{ mA}$	30	_		
Collector-emitter saturation voltage	V <sub>CE (sat)</sub>	$I_{C} = -5 \text{ mA}, I_{B} = -0.25 \text{ mA}$		-0.1	-0.3	V
Input voltage (ON)	V <sub>I (ON)</sub>	$V_{CE} = -0.2$ V, $I_C = -5$ mA	-1.1	_	-2.0	V
Input voltage (OFF)	VI (OFF)	$V_{CE} = -5 \text{ V}, \text{ I}_{C} = -0.1 \text{ mA}$	-1.0	_	-1.5	V
Transition frequency	f <sub>T</sub>	$V_{CE} = -10 \text{ V}, \text{ I}_{C} = -5 \text{ mA}$		200		MHz
Collector output capacitance	C <sub>ob</sub>	$V_{CB} = -10 \text{ V}, \text{ I}_{E} = 0, \text{ f} = 1 \text{ MHz}$	—	3	6	pF

### **Electrical Characteristics (Ta = 25°C) (Q2)**

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I <sub>CBO</sub>	$V_{CB} = 50 \text{ V}, I_E = 0$	_		100	nA
	ICEO	$V_{CE}=50~V,~I_B=0$	_	_	500	
Emitter cut-off current	I <sub>EBO</sub>	$V_{EB} = 10 \text{ V}, \text{ I}_{C} = 0$	0.82	_	1.52	mA
DC current gain	h <sub>FE</sub>	$V_{CE} = 5 \text{ V}, \text{ I}_{C} = 10 \text{ mA}$	30	_	_	
Collector-emitter saturation voltage	V <sub>CE (sat)</sub>	$I_{C} = 5 \text{ mA}, I_{B} = 0.25 \text{ mA}$	_	0.1	0.3	V
Input voltage (ON)	V <sub>I (ON)</sub>	$V_{CE} = 0.2 \text{ V}, I_{C} = 5 \text{ mA}$	1.1	_	2.0	V
Input voltage (OFF)	V <sub>I (OFF)</sub>	$V_{CE} = 5 \text{ V}, \text{ I}_{C} = 0.1 \text{ mA}$	1.0	_	1.5	V
Transition frequency	f <sub>T</sub>	$V_{CE} = 10 \text{ V}, I_{C} = 5 \text{ mA}$		250		MHz
Collector output capacitance	C <sub>ob</sub>	$V_{CB} = 10 \text{ V}, \text{ I}_{E} = 0, \text{ f} = 1 \text{ MHz}$		3	6	pF

### Electrical Characteristics (Ta = 25°C) (Q1, Q2 common)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input resistor	R1	_	3.29	4.7	6.11	kΩ
Resistor ratio	R1/R2	—	0.9	1.0	1.1	

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